





Attorney Docket No. 5000.142 TEM &

Patent

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Tuttle et al.

Group Art Unit 2811

Serial No. 10/045,766 Filing Date: 01/15/2002

Title: PATTERN FOR IMPROVED VISUAL

INSPECTION OF SEMICONDUCTOR DEVICES

June 20, 2002

Assistant Commissioner for Patents Washington, DC 20231

PETITION FOR TWO-MONTH EXTENSION OF TIME UNDER 37 CFR 1.136(A)

Sir:

This is a request under the provisions of 37 CFR 1.136(a) for a two-month extension of time to file a response in the above application. Enclosed is our check for \$400, the required large-entity fee under 37 CFR 1.17(a)(2). The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment, to Deposit Account No. 50-0332. A duplicate copy of this sheet is enclosed.

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/ (Wy)

Respectfully submitted.

Reg. No. 31,573

021176

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CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, DC, on June 20, 2002.

Philip Summa

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